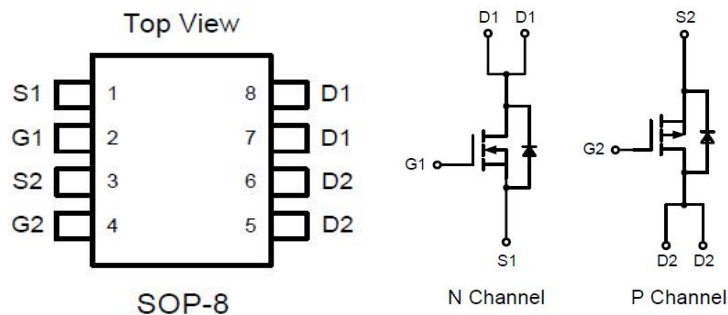




## GENERAL DESCRIPTION

The RZC4606A uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.

## PIN CONFIGURATION



## FEATURES

- N-Channel  
30V/7A,  
 $R_{DS(ON)}=24m\Omega$  (TYP.) @  $V_{GS}=10V$   
 $R_{DS(ON)}=34m\Omega$  (TYP.) @  $V_{GS}=4.5V$
- P-Channel  
-30V/-5.3A,  
 $R_{DS(ON)}=53m\Omega$  (TYP.) @  $V_{GS}=-10V$   
 $R_{DS(ON)}=80m\Omega$  (TYP.) @  $V_{GS}=-4.5V$
- Super High Dense Cell Design
- Reliable and Rugged

## APPLICATIONS

- Power Management in Notebook Computer
- Wireless Charger
- FAN Driver
- Portable Equipment
- Battery Powered Systems

## ORDERING INFORMATION

Part Number	Package	Top Marking	Packing
RZC4606A	SOP-8	4606A	3000PCS/Real

**MAXIMUM RATINGS** ( $T_a = 25^\circ\text{C}$ )

Parameter	Symbol	Value		Units	
		N	P		
Drain to Source Voltage	$V_{DSS}$	30	-30	V	
Gate to Source Voltage	$V_{GSS}$	$\pm 20$	$\pm 25$	V	
Continuous Drain Current	$I_D$	25 $^\circ\text{C}$	7	-5.3	A
		85 $^\circ\text{C}$	5.6	-4.2	A
Pulsed Drain Current	$I_{D(pulse)}$	28	-21	A	
Maximum Power Dissipation	$P_D(25^\circ\text{C})$	2		W	
Operating Junction Temperature	$T_J$	+150		$^\circ\text{C}$	
Storage Temperature	$T_{STG}$	-55-+150		$^\circ\text{C}$	
Lead Temperature for Soldering Purposes(1/8" from case for 10 s)	$T_L$	260		$^\circ\text{C}$	

**ELECTRICAL CHARACTERISTICS** (TA = 25°C)

## N-Channel

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units
Drain-Source Breakdown Voltage	BVDSS	V <sub>GS</sub> =0V, I <sub>DS</sub> =250uA	30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30V, V <sub>GS</sub> =0V			1	uA
Gate Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
Gate threshold voltage	V <sub>GS(TH)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> = 250μA	1.3	1.7	2.1	V
Drain to Source On-state Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =3.0A		24	35	mΩ
		V <sub>GS</sub> = 4.5V, I <sub>D</sub> =3.0A		34	45	mΩ
Drain-Source Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =0.5A, V <sub>GS</sub> =0V		0.8	1.3	V
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, f=1MHz		560		pF
Output Capacitance	C <sub>OSS</sub>			125		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			90		pF
Total Gate Charge	Q <sub>G</sub>	V <sub>DS</sub> =-0V, V <sub>GS</sub> =10V, I <sub>D</sub> =3A		7		nC
Gate-Source Charge	Q <sub>GS</sub>			1.5		nC
Gate-Drain Charge	Q <sub>GD</sub>			3		nC



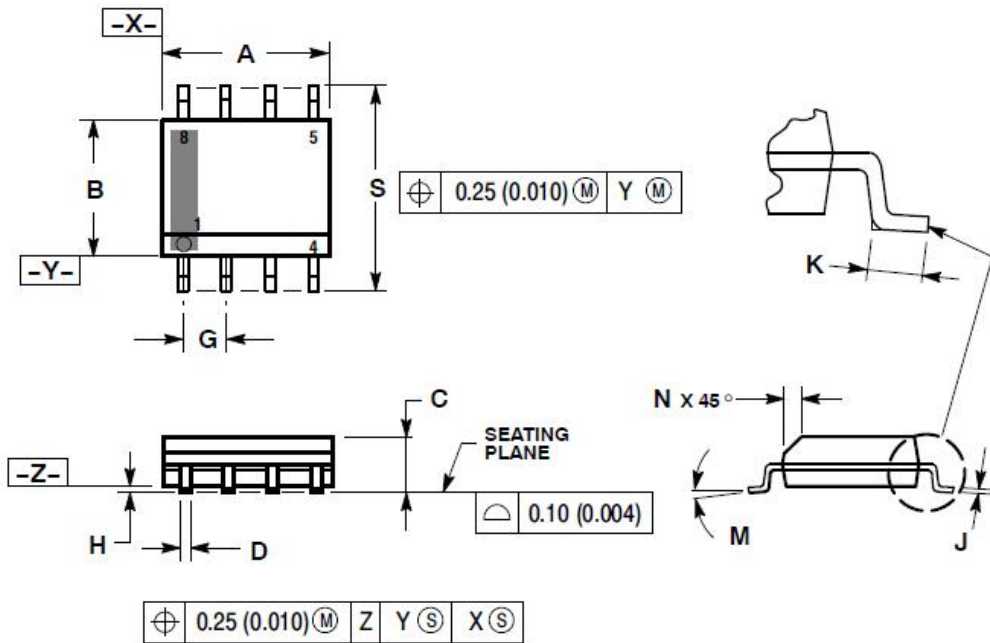
## P-Channel

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units
Drain-Source Breakdown Voltage	BVDSS	$V_{GS}=0V, I_{DS}=250\mu A$	-30			V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=-30V, V_{GS}=0V$			-1	$\mu A$
Gate Leakage Current	$I_{GSS}$	$V_{GS}=\pm 25V, V_{DS}=0V$			$\pm 100$	nA
Gate threshold voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	-1.0	-1.6	-2.5	V
Drain to Source On-state Resistance	$R_{DS(on)}$	$V_{GS}=-10V, I_D=-3.0A$		48	58	m $\Omega$
		$V_{GS}=-4.5V, I_D=-3.0A$		65	85	m $\Omega$
Drain-Source Diode Forward Voltage	$V_{SD}$	$I_S=-1.7A, V_{GS}=0V$		-0.7	-1.3	V
Input Capacitance	$C_{ISS}$	$V_{DS}=-30V, V_{GS}=0V, f=1MHz$		580		pF
Output Capacitance	$C_{OSS}$			98		pF
Reverse Transfer Capacitance	$C_{RSS}$			74		pF
Total Gate Charge	$Q_G$	$V_{DS}=-30V, V_{GS}=-10V, I_D=-3A$		10		nC
Gate-Source Charge	$Q_{GS}$			2		nC
Gate-Drain Charge	$Q_{GD}$			3		nC



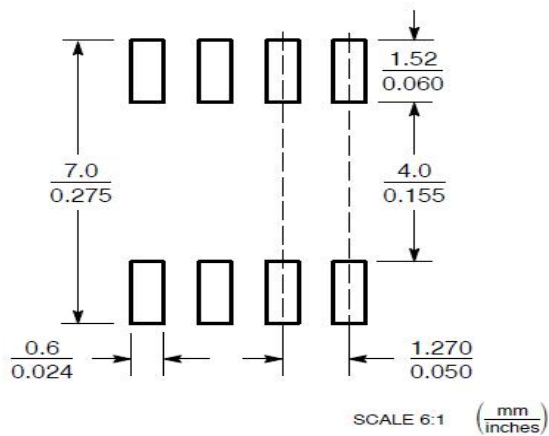
PACKAGE DIMENSIONS

SOP-8



⊕ 0.25 (0.010) (M) Z Y (S) X (S)

SOLDERING FOOTPRINT\*



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.80	5.00	0.189	0.197
B	3.80	4.00	0.150	0.157
C	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27 BSC		0.050 BSC	
H	0.10	0.25	0.004	0.010
J	0.19	0.25	0.007	0.010
K	0.40	1.27	0.016	0.050
M	0 °	8 °	0 °	8 °
N	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244